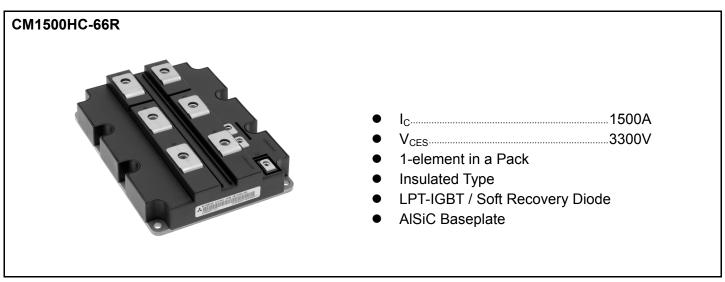


< HVIGBT MODULES >

CM1500HC-66R

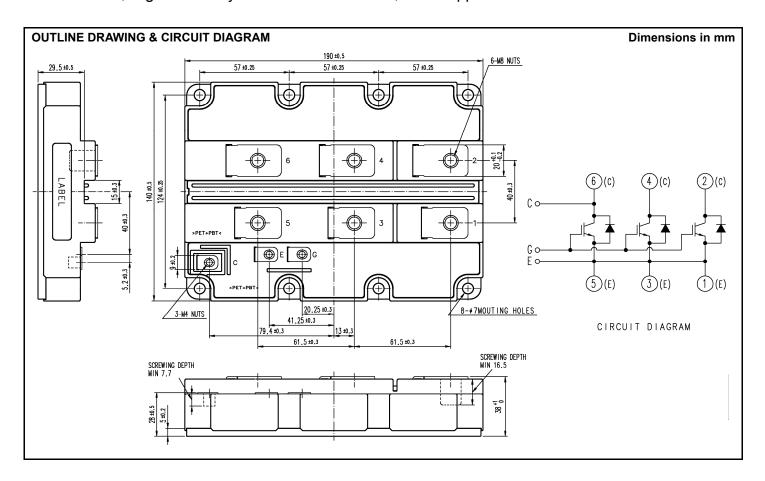
HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
V_{CES}	Callector emitter veltage	$V_{GE} = 0V, T_j = -40+150$ °C	3300	
	Collector-emitter voltage	$V_{GE} = 0V, T_{j} = -50^{\circ}C$	3200	V
V_{GES}	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^{\circ}C$	± 20	V
Ic	0 " 1	DC, $T_c = 95^{\circ}C$	1500	Α
I _{CRM}	Collector current	Pulse (Note 1)	3000	Α
I _E	Freitten europt	DC	1500	Α
I _{ERM}	Emitter current (Note 2)	Pulse (Note 1)	3000	Α
P _{tot}	Maximum power dissipation (Note 3)	T _c = 25°C, IGBT part	15600	W
V _{iso}	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min.	6000	V
V _e	Partial discharge extinction voltage	RMS, sinusoidal, f = 60Hz, Q _{PD} ≤ 10 pC	2600	V
T _j	Junction temperature		-50 ~ +150	°C
T _{jop}	Operating junction temperature		− 50 ~ +150	°C
T_{stg}	Storage temperature		− 55 ~ +150	°C
t _{psc}	Short circuit pulse width	$V_{CC} = 2500V, V_{CE} \le V_{CES}, V_{GE} = 15V, T_j = 150$ °C	10	μS

ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions			Limits	Unit	
Cymbol	item	Conditions		Min	Тур	Max	Onne
I _{CES}	Collector cutoff current		T _j = 25°C	_	_	6.0	
		$V_{CE} = V_{CES}, V_{GE} = 0V$	T _j = 125°C	_	6.0	_	mA
			T _j = 150°C	_	36.0	_	
$V_{GE(th)}$	Gate-emitter threshold voltage	$V_{CE} = 10 \text{ V}, I_{C} = 150 \text{ mA}, T_{j} = 25^{\circ}\text{C}$		5.7	6.2	6.7	V
I _{GES}	Gate leakage current	$V_{GE} = V_{GES}$, $V_{CE} = 0V$, $T_j = 25$ °C		-0.5	_	0.5	μΑ
C _{ies}	Input capacitance	V _{CE} = 10 V, V _{GE} = 0 V, f = 100 kHz			210.0	_	nF
C _{oes}	Output capacitance	$T_i = 25^{\circ}C$		_	13.0	_	nF
C _{res}	Reverse transfer capacitance	1) 20 0		_	6.0	_	nF
Q_G	Total gate charge	$V_{CC} = 1800V, I_{C} = 1500A, V_{GE} = \pm 15V$		_	16.0	_	μC
		I _C = 1500 A ^(Note 4)	$T_j = 25^{\circ}C$	_	2.45	_	
V _{CEsat}	Collector-emitter saturation voltage	V _{GE} = 15 V	T _j = 125°C	_	3.10	3.70	V
		V _{GE} - 15 V	T _j = 150°C	_	3.25	_	
			T _j = 25°C	_	1.00	_	
t _{d(on)}	Turn-on delay time		T _j = 125°C	_	0.95	1.25	μs
			T _j = 150°C	_	0.95	1.25	
	Turn-on rise time	V _{CC} = 1800 V I _C = 1500 A	T _j = 25°C	_	0.28	_	
t _r			T _j = 125°C	_	0.30	0.50	μs
		V _{GE} = ±15 V	T _j = 150°C	_	0.30	0.50	
		$R_{G(on)} = 1.6 \Omega$	T _i = 25°C	_	2.10	_	
E _{on(10%)}	Turn-on switching energy (Note 5)	L _s = 100 nH	T _i = 125°C	_	2.75	_	J
		Inductive load	T _i = 150°C	_	3.00	_	
	Turn-on switching energy (Note 6)		T _i = 25°C	_	2.20	_	
Eon			T _i = 125°C	_	2.90	_	J
			T _i = 150°C	_	3.20	_	
			T _i = 25°C	_	2.70	_	
$t_{d(off)}$	Turn-off delay time		T _i = 125°C	_	2.80	3.30	μs
			T _i = 150°C		2.85	3.30	
		V _{CC} = 1800 V	T _i = 25°C	_	0.30	_	
t _f	Turn-off fall time	I _C = 1500 A	T _i = 125°C	_	0.35	1.00	μs
		$V_{GE} = \pm 15 \text{ V}$	T _i = 150°C		0.40	1.00	I
		$R_{G(off)} = 5.6 \Omega$	T _i = 25°C		2.00	_	
E _{off(10%)}	Turn-off switching energy (Note 5)	L _s = 100 nH	T _i = 125°C		2.45	_	J
011(1070)		Inductive load	T _i = 150°C		2.50	_	
		· · · · · · · · · · · · · · · · · · ·	T _i = 25°C		2.20	_	
E _{off}	Turn-off switching energy (Note 6)		T _i = 125°C	_	2.70	_	J
Loff	Tam-on switching energy	<u> </u>	T _i = 150°C	_	2.80	_	
			1 .,	l .		1	

< HVIGBT MODULES >

CM1500HC-66R

HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

ELECTRICAL CHARACTERISTICS (continuation)

Symbol	Item		Conditions			Limits		Unit
Syllibol	пеш	Conditions		Min	Тур	Max	Offic	
	Emitter-collector voltage (Note 2		I _E = 1500 A ^(Note 4)	T _j = 25°C	_	2.15	_	
V_{EC}		(Note 2)		T _j = 125°C	_	2.30	2.80	V
			$V_{GE} = 0 V$	T _j = 150°C	_	2.25	_	
				T _j = 25°C	_	0.50	_	
t _{rr}	Reverse recovery time	(Note 2)		T _j = 125°C	_	0.70		μs
				T _j = 150°C	_	0.80		
				T _j = 25°C	_	1250	l	
Irr	Reverse recovery current	(Note 2)	1000 \	T _j = 125°C	_	1500	l	Α
			V _{CC} = 1800 V	$T_{j} = 150^{\circ}C$	_	1550	I	
			I _C = 1500 A V _{GF} = ±15 V	T _j = 25°C	_	1050	l	
Q_{rr}	Reverse recovery charge	(Note 2)	*=	T _j = 125°C	_	1700		μC
			$R_{G(on)} = 1.6 \Omega$ $L_s = 100 \text{ nH}$	$T_{j} = 150^{\circ}C$	_	2000	1	
E _{rec(10%)}	Boyerse receivery energy	(Note 2)	Inductive load	$T_j = 25^{\circ}C$		1.05		μs A
	Reverse recovery energy	(Note 5)	inductive load	T _j = 125°C	_	1.75		J
				T _j = 150°C	_	2.00	l	
E _{rec}	Davis	(Note 2)		$T_j = 25^{\circ}C$		1.20	_	
	Reverse recovery energy	(Note 6)		T _j = 125°C	_	2.00		J
				T _j = 150°C	_	2.30		

THERMAL CHARACTERISTICS

Symbol	Itam	Conditions	Limits			Unit
	Item	Conditions	Min	Тур	Max	Offic
$R_{th(j-c)Q}$	Thermal resistance	Junction to Case, IGBT part		_	8.0	K/kW
R _{th(j-c)D}		Junction to Case, FWDi part	_	_	15.0	K/kW
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, λ _{grease} = 1W/m [*] k, D _(c-s) = 100μm		6.0	_	K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
	item	Conditions	Min	Тур	Max	Unit
M_t		M8 : Main terminals screw	7.0	1	22.0	N⋅m
Ms	Mounting torque	M6 : Mounting screw	3.0	-	6.0	N⋅m
M_t		M4 : Auxiliary terminals screw	1.0		3.0	N⋅m
m	Mass		1	1.2	-	kg
CTI	Comparative tracking index		600	1		_
d _a	Clearance		19.5	_	_	mm
ds	Creepage distance		32.0	1	-	mm
L _{P CE}	Parasitic stray inductance		1	11.0	-	nΗ
R _{CC'+EE'}	Internal lead resistance	$T_C = 25^{\circ}C$	_	0.12	_	mΩ
r_{g}	Internal gate resistance	T _C = 25°C	_	1.5	_	Ω

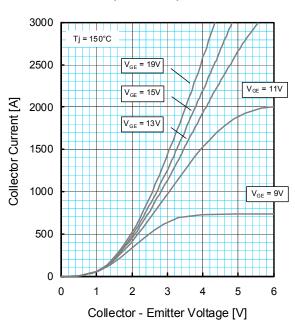
Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{opmax} rating(150°C).

- 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD_i).
- 3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).
- 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.
- 5. $E_{on(10\%)}$ / $E_{off(10\%)}$ / $E_{rec(10\%)}$ are the integral of 0.1 V_{CE} x 0.1 I_C x dt.
- 6. Definition of all items is according to IEC 60747, unless otherwise specified.

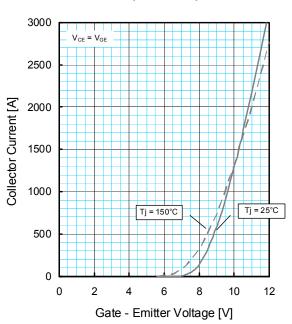
PERFORMANCE CURVES

INSULATED TYPE

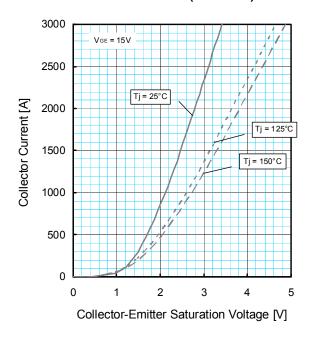
OUTPUT CHARACTERISTICS (TYPICAL)



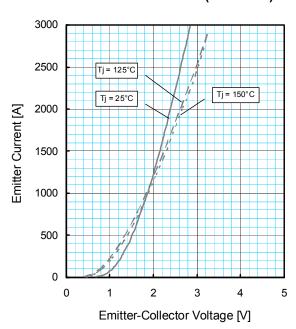
TRANSFER CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



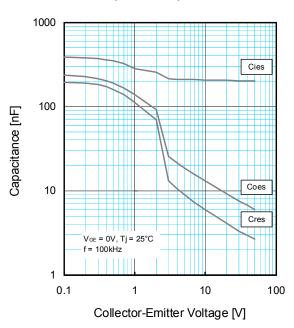
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



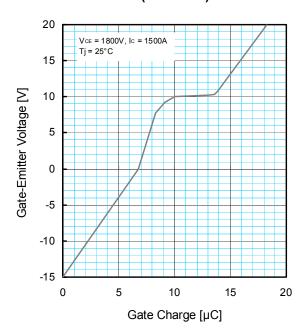
PERFORMANCE CURVES

INSULATED TYPE

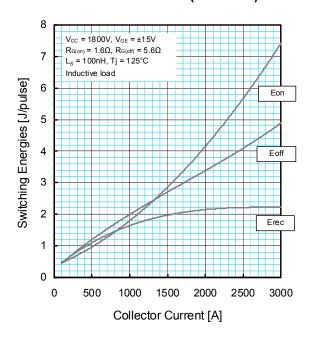
CAPACITANCE CHARACTERISTICS (TYPICAL)



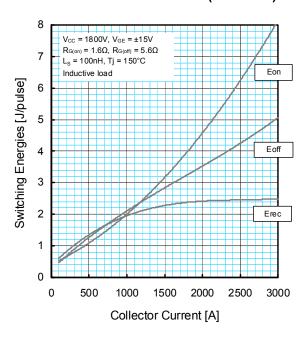
GATE CHARGE CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



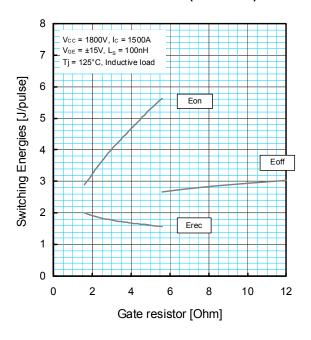
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



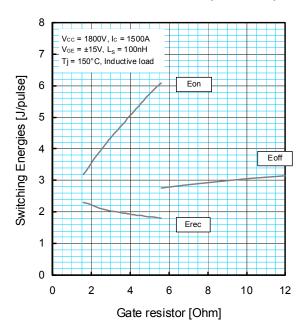
CM1500HC-66R HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES

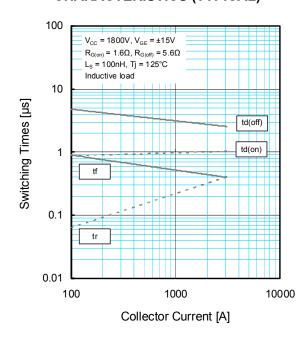
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



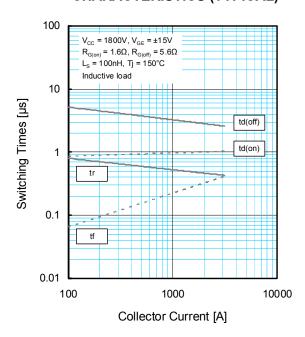
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



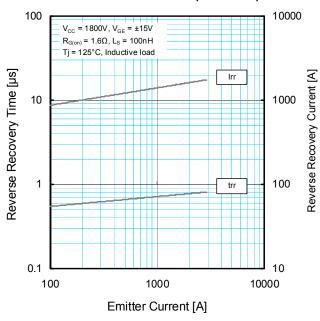
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)



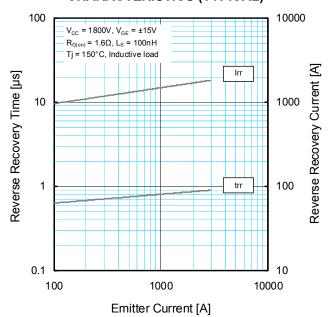
CM1500HC-66R HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES

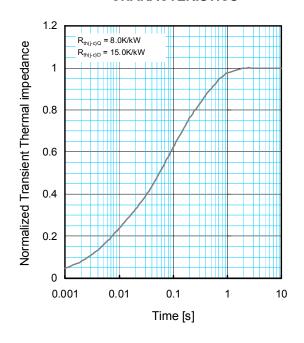
FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



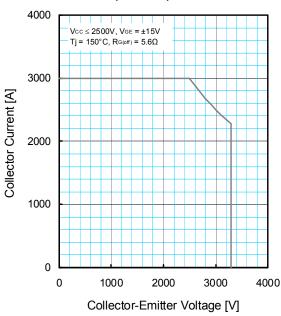
$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - \exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$$

$$\frac{1}{R_{i} [\text{K/kW}]:} \begin{array}{c|cccc} 1 & 2 & 3 & 4 \\ 0.0096 & 0.1893 & 0.4044 & 0.3967 \\ \hline \tau_{i} [\text{sec}]: & 0.0001 & 0.0058 & 0.0602 & 0.3512 \\ \end{array}$$

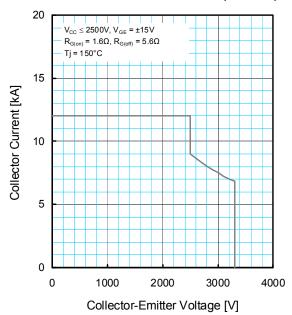
PERFORMANCE CURVES

INSULATED TYPE

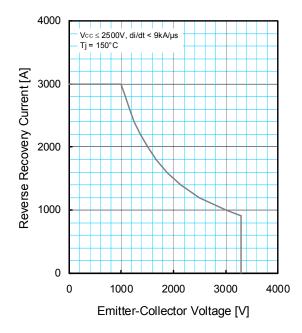
REVERSE BIAS SAFE OPERATING AREA (RBSOA)



SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



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